## Notice of References Cited Application/Control No. 10/041,845 Examiner David A. Lambertson Applicant(s)/Patent Under Reexamination LEVINE ET AL. Art Unit Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,358,739	03-2002	Baetge et al.	435/377
	В	US-			
	С	US-			
	D	US-			
	Ε	US-			
	F	US-			
	G	US-			
	H	US-			
	1	US-			
	J	US-			
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## FOREIGN PATENT DOCUMENTS

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## NON-PATENT DOCUMENTS

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